

<b>Notice of References Cited</b>	Application/Control No. 10/578,988		Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner Jennifer Dieterle		Art Unit 4111	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,385,846	01-1995	Kuhn et al.	205/777.5
*	B	US-6,632,349	10-2003	Hodges et al.	205/792
*	C	US-3,922,598	11-1975	Steuer et al.	324/442
*	D	US-2004/0005721	01-2004	Tanike et al.	436/518
*	E	US-6,287,451	09-2001	Winarta et al.	205/777.5
*	F	US-2003/0098234	05-2003	Hasegawa et al.	204/403.04
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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